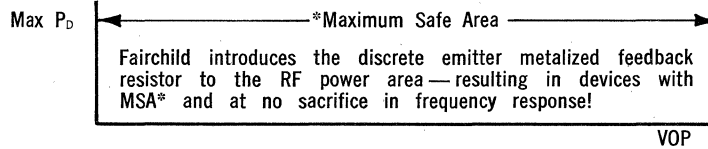


RF Power Transistors

RF POWER TRANSISTOR OPERATIONAL ADVANTAGES



All Fairchild RF Power devices with ratings of 10 Watts and above have MSA thus eliminating the need for costly protective circuitry.

RF POWER DEVICE APPLICATION SPECTRUM SELECTION GUIDE

Application	Freq.	Voltage	Predriver	Driver	Output			
	MHz	Volts	.1 → 1	3-5	5W	10W	25W	50W
Military FM/SSB	2-76							
Ham SSB	HF	12	2N4427	2N3553			2N5025	
Lo Band Mobile FM	25-50							
RC Model Air-AM	72	28	2N3866			MSA 7505		
Overseas Mobile FM	66-68		2N3866	2N3553			2N5026	
Aircraft AM	108-152	12	2N4427		MSA 7505			
VHF Mobile FM	152-174	28	2N3866			MSA 7505		
Port. & Marine FM	152-174		2N3866	2N3375				
Sonobouy FM	175	28	2N3866	MSA 7505				MSA 7503
Military AM	225-400							
Beacons AM CW	243							
Aero Glide	328-335	28	2N3866	2N3375		MSA 7505		
Portable FM	450-470		2N3866	MSA 7505			MSA 7504	
CB FM	462-470							
Fuse Osc.	400-600	28	2N3866					

NPN SILICON PLANAR EPITAXIAL TRANSISTORS

RF Power
TBV0505XXX

Maximum Ratings

Maximum Junction Temperature	+200°C
Storage Temperature	-65°C to +200°C

Maximum Power Dissipation

Total Dissipation, 25°C Case Temperature	23W*
--	------

Electrical Characteristics (25°C Free Air)

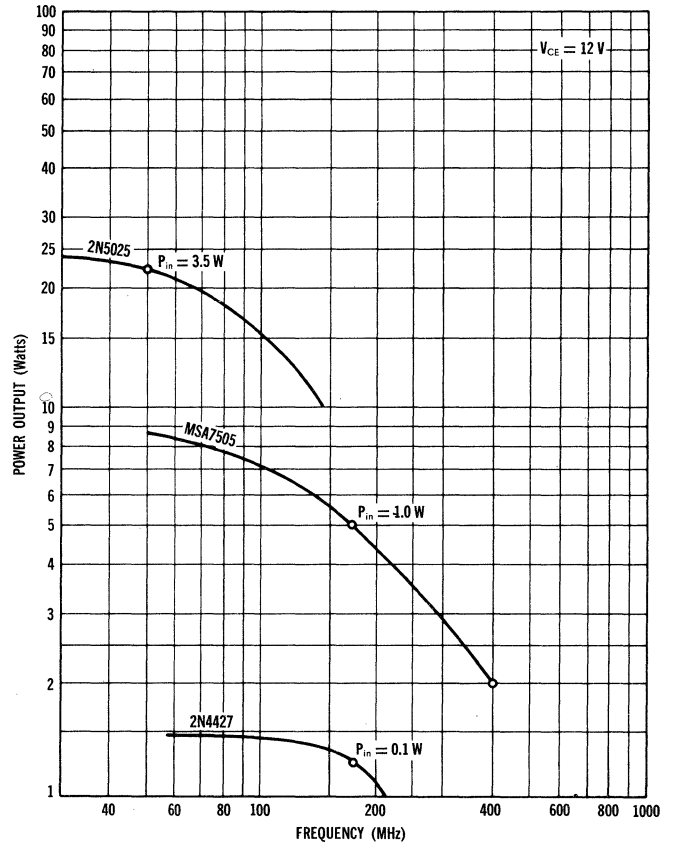
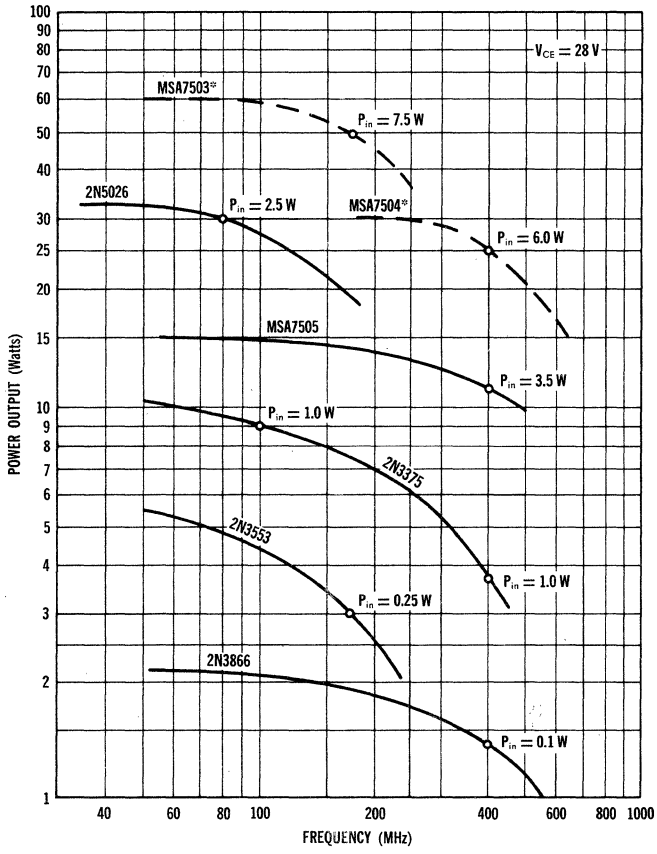
Parameter	Min	Max	Units	Test Conditions
V _{CEO}	33		Volts	I _C = 50mA
BV _{CES}	65		Volts	I _C = 1.0mA
BV _{EBO}	4.0		Volts	I _E = 1.0mA
h _{FE}	10	150		I _C = 250mA, V _{CE} = 5V
V _{BE(sat)}		1.30	Volts	I _C = 1.0A, I _B = 200mA
h _{fe}	4.0			I _C = 500mA, V _{CE} = 5V f = 100MHz
P _O	10.0		Watt	V _{CC} = 28V, P _{in} = 1W f = 100MHz

*Derating factor of 7.5° C/W

RF POWER TRANSISTORS NUMERICAL INDEX

Type	Page No.	Type	Page No.	Type	Page No.
2N3375	17-2	2N5025	17-8	MSA8505	17-10
2N3553	17-2	2N5026	17-8		
2N3866	17-6	MSA7505	17-10		

RF POWER TRANSISTORS



2N3375 • 2N3553

NPN LARGE SIGNAL UHF POWER AMPLIFIER

DIFFUSED SILICON PLANAR* EPITAXIAL TRANSISTORS

GENERAL DESCRIPTION—The 2N3375 and 2N3553 are NPN diffused silicon Planar* epitaxial transistors designed primarily for use in large signal VHF and UHF power amplifier output stages.

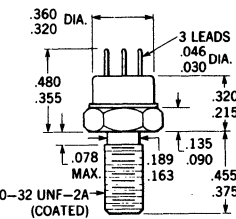
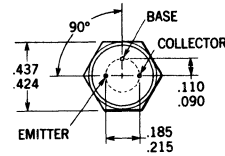
ABSOLUTE MAXIMUM RATINGS (Note 1)

Maximum Temperatures			
Storage Temperature		-65°C to +200°C	
Operating Case Temperature		-65°C to +200°C	
Maximum Power Dissipation (Notes 2 and 3)			
Total Dissipation at 25°C Case Temperature	2N3375	2N3553	
	11.6 Watts	7.0 Watts	
Maximum Voltages and Current			
V _{CBO}	Collector to Base Voltage	65 Volts	65 Volts
V _{CEO}	Collector to Emitter Voltage	40 Volts	40 Volts
V _{EBO}	Emitter to Base Voltage	4.0 Volts	4.0 Volts
I _C	Collector Current	1.5 Amps	1.0 Amps

2N3375

PHYSICAL DIMENSIONS

In accordance with JEDEC (TO-60)

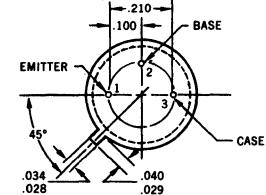
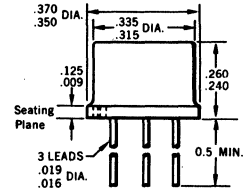


NOTES: All dimensions in inches
Leads are nickel-plated kovar
All leads are isolated from case
Package weight is 4.8 grams

2N3553

PHYSICAL DIMENSIONS

in accordance with JEDEC (TO-39) outline



NOTES: All dimensions in inches
Leads are gold-plated KOVAR
Lead No. 3 internally connected to case
Package weight is 1.23 grams

ELECTRICAL CHARACTERISTICS (25°C Case Temperature unless otherwise noted)

SYMBOL	CHARACTERISTICS	2N3375		2N3553		UNITS	TEST CONDITIONS	
		MIN.	MAX.	MIN.	MAX.			
P _{out}	RF Power Output (f = 400 MHz, Fig. 1)	3.0				Watts	V _{CE} = 28 V	P _{IN} = 1.0 W
η	Collector Efficiency (f = 400 MHz, Fig. 1)	40				%	V _{CE} = 28 V	P _{IN} = 1.0 W
P _{out}	RF Power Output (f = 175 MHz, Fig. 2)			2.5		Watts	V _{CE} = 28 V	P _{IN} = 0.25 W
η	Collector Efficiency (f = 175 MHz, Fig. 2)			50		%	V _{CE} = 28 V	P _{IN} = 0.25 W
P _{out}	RF Power Output (f = 100 MHz, Fig. 2)	7.5				Watts	V _{CE} = 28 V	P _{IN} = 1.0 W
η	Collector Efficiency (f = 100 MHz, Fig. 2)	65				%	V _{CE} = 28 V	P _{IN} = 1.0 W
h _{FE}	DC Pulse Current Gain (Note 4)	10	100	10	100		I _C = 250 mA	V _{CE} = 5.0 V
h _{FE}	DC Pulse Current Gain (Note 4)		200		200		I _C = 125 mA	V _{CE} = 5.0 V
h _{fe}	High Frequency Current Gain (f = 100 MHz)	4.0		4.0			I _C = 125 mA	V _{CE} = 28 V

Additional Electrical Characteristics on page 2

*Planar is a patented Fairchild process.

NOTES:

- These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- These ratings give a maximum junction temperature of 200°C and junction to case thermal resistance of 15°C/Watt (derating factor of 66 mW/°C) for the 2N3375 and 25°C/Watt (derating factor of 40 mW/°C) for the 2N3553.
- Pulse Conditions: length = 300 μs; duty cycle ≤ 2%.
- Pulsed through a 25 mH Inductor.

FAIRCHILD
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313 FAIRCHILD DRIVE, MOUNTAIN VIEW, CALIFORNIA, (415) 962-5011, TWX: 910-379-6435

FAIRCHILD TRANSISTORS 2N3375 • 2N3553

ELECTRICAL CHARACTERISTICS (25 °C Case Temperature unless otherwise noted)

SYMBOL	CHARACTERISTICS	2N3375		2N3553		UNITS	TEST CONDITIONS	
		MIN.	MAX.	MIN.	MAX.			
$V_{CE(sat)}$	Pulsed Collector Saturation Voltage (Note 4)		1.0		1.0	Volts	$I_C = 250 \text{ mA}$	$I_B = 50 \text{ mA}$
$V_{CEO(sust)}$	Collector to Emitter Sustaining Voltage (Note 5)	40		40		Volts	$I_C = 200 \text{ mA}$	$I_B = 0$
$V_{CER(sust)}$	Collector to Emitter Sustaining Voltage (Note 5)	40		40		Volts	$I_C = 200 \text{ mA}$	$R_{BE} = 100 \Omega$
I_{CEO}	Collector Cutoff Current		0.1		0.1	mA	$V_{CE} = 30 \text{ V}$	$I_B = 0$
I_{EBO}	Emitter Cutoff Current		0.1		0.1	mA	$V_{EB} = 4.0 \text{ V}$	
I_{CEX}	Collector Cutoff Current		1.0		1.0	mA	$V_{CE} = 65 \text{ V}$	$V_{BE} = -1.5 \text{ V}$
$I_{CEX(+200^\circ\text{C})}$	Collector Cutoff Current		5.0		5.0	mA	$V_{CE} = 30 \text{ V}$	$V_{BE} = -1.5 \text{ V}$
C_{obo}	Common Base, Open Circuit Output Capacitance ($f = 1.0 \text{ MHz}$)		10		10	pF	$V_{CB} = 30 \text{ V}$	$I_E = 0$

FIGURE 1
RF AMPLIFIER CIRCUIT FOR 2N3375 - POWER-OUTPUT TEST
(400-MHz Operation)

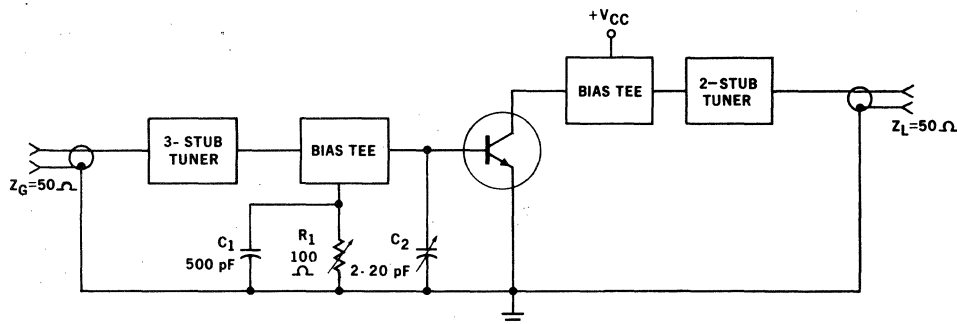
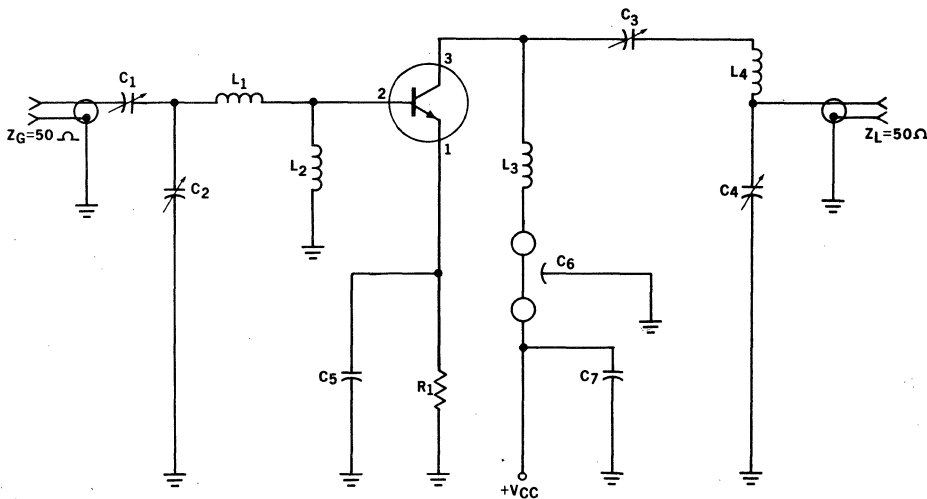


FIGURE 2
RF AMPLIFIER CIRCUIT FOR 2N3375 & 2N3553 - POWER-OUTPUT TEST
(100 & 175-MHz Operation)



For 2N3375 100-MHz Operation:

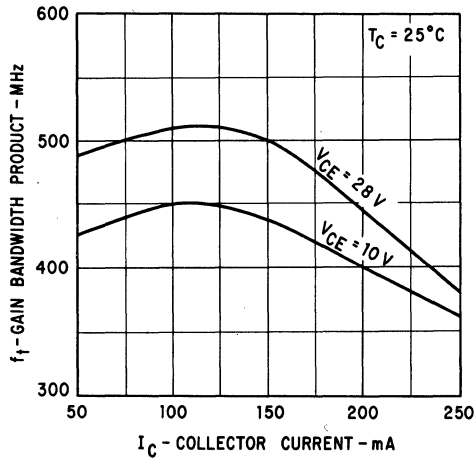
- C_1, C_2 : 7-100 pF
- C_3, C_4 : 4-40 pF
- C_5 : 330 pF, disc ceramic
- C_6 : 1500 pF
- C_7 : 0.005 μF , disc ceramic
- L_1 : 3 turns No. 16 wire, $1/4$ " ID, $5/16$ " long
- L_2 : Ferrite choke, $Z = 750 (\pm 20\%)$ ohms
- L_3 : 2.4 μH choke
- L_4 : 5 turns No. 16 wire, $5/16$ " ID, $7/16$ " long
- R_1 : 1.35 ohms, non-inductive

For 2N3553 175-MHz Operation:

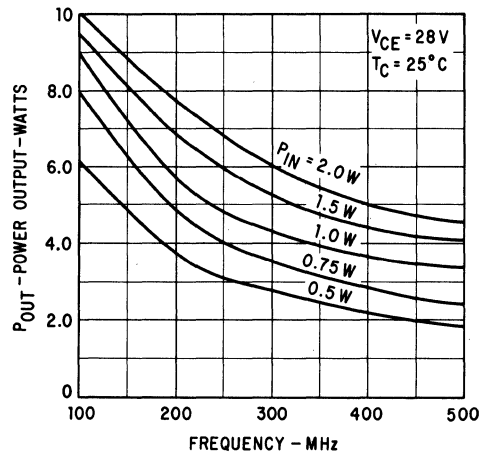
- C_1, C_2, C_3, C_4 : 3-35 pF
- C_5 : Not used
- C_6 : 1,000 pF
- C_7 : 0.005 μF , disc ceramic
- L_1 : 2 turns No. 16 wire, $3/16$ " ID, $1/4$ " long
- L_2 : Ferrite choke, $Z = 450$ ohms
- L_3 : 2 turns No. 16 wire, $1/4$ " ID, $1/4$ " long
- L_4 : 4 turns No. 16 wire, $3/8$ " ID, $3/8$ " long
- R_1 : Not used (emitter connected to ground)

TYPICAL PERFORMANCE CHARACTERISTICS
2N3375

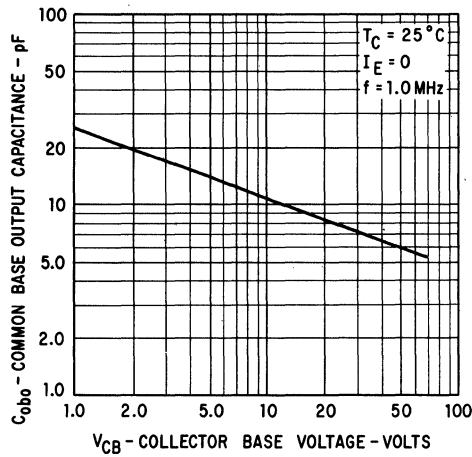
GAIN - BANDWIDTH PRODUCT
VERSUS COLLECTOR CURRENT



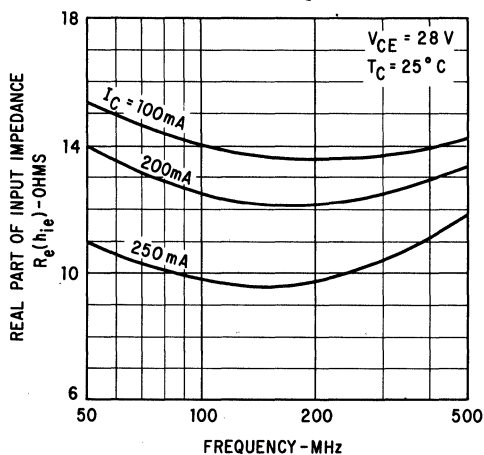
POWER OUTPUT
VERSUS FREQUENCY



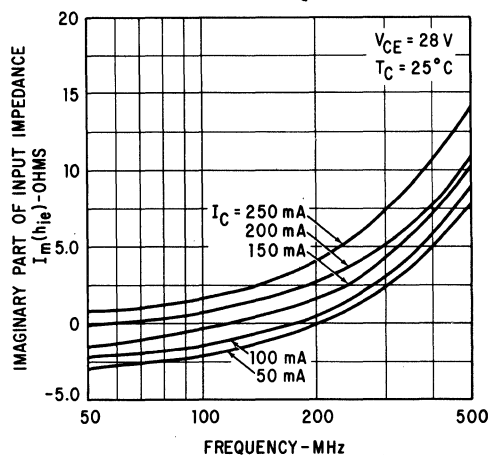
COMMON BASE OUTPUT
CAPACITANCE VERSUS
COLLECTOR BASE VOLTAGE



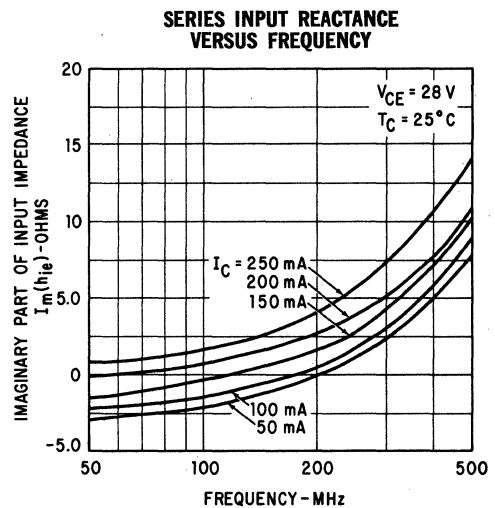
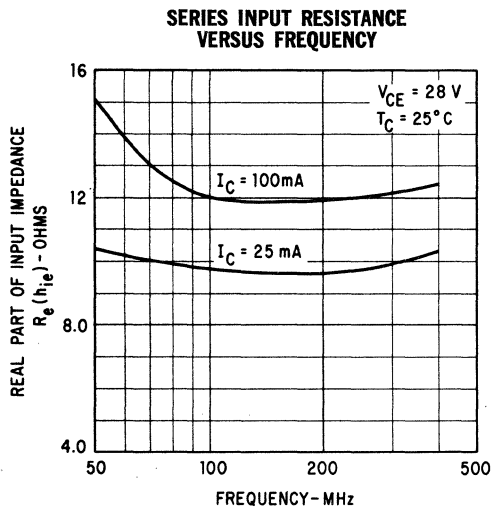
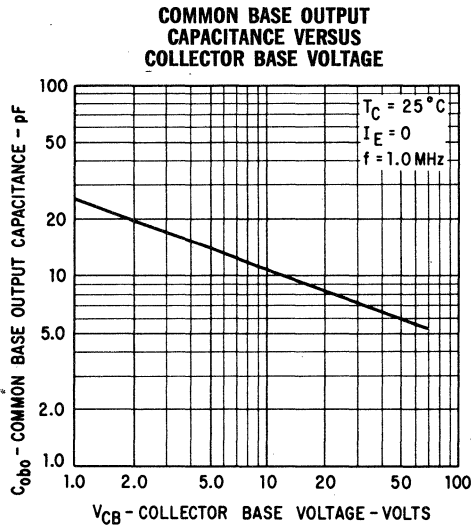
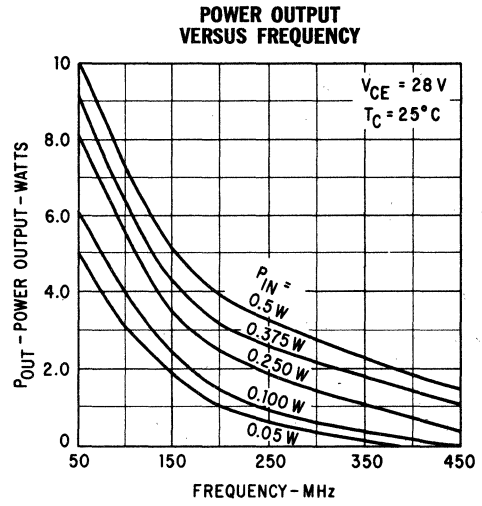
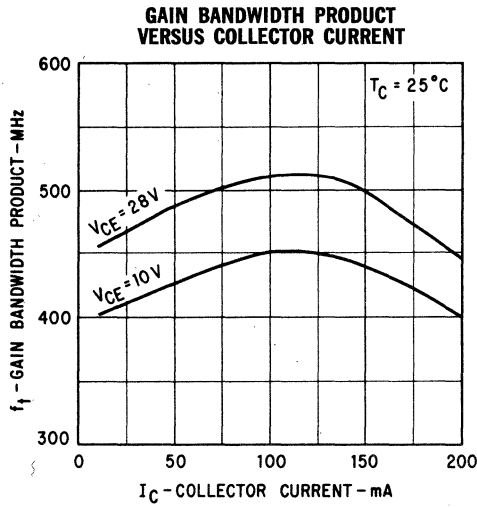
SERIES INPUT RESISTANCE
VERSUS FREQUENCY



SERIES INPUT REACTANCE
VERSUS FREQUENCY



TYPICAL PERFORMANCE CHARACTERISTICS
2N3553



2N3866

NPN VHF-UHF OSCILLATOR, POWER AMPLIFIER

DIFFUSED SILICON PLANAR* EPITAXIAL TRANSISTOR

GENERAL DESCRIPTION — The 2N3866 is a NPN, silicon epitaxial planar transistor designed for class A, B, or C amplifier circuits and VHF-UHF oscillator applications.

ABSOLUTE MAXIMUM RATINGS (Note 1)

Maximum Temperatures

Storage Temperature

−65°C to +200°C

Operating Junction Temperature

−65°C to +200°C

Maximum Power Dissipation (Notes 2 and 3)

Total Dissipation at 25°C Case Temperature

5.0 Watts

Maximum Voltages and Currents

V_{CEO} Collector to Emitter Voltage (Note 4)

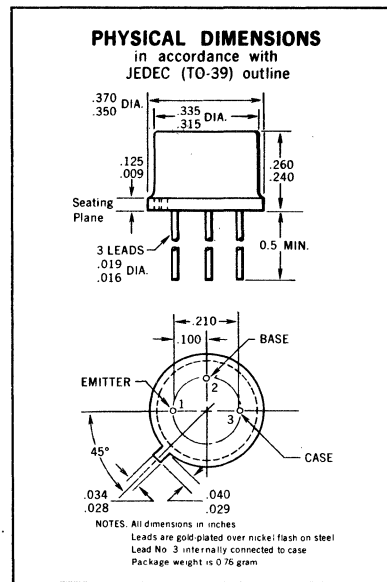
30 Volts

V_{EBO} Emitter to Base Voltage

3.5 Volts

V_{CES} Collector to Emitter Voltage

55 Volts



ELECTRICAL CHARACTERISTICS (25°C Case Temperature unless otherwise noted)

SYMBOL	CHARACTERISTICS	MIN.	MAX.	UNITS	TEST CONDITIONS
P_{out}	RF Power Out (f = 400 MHz)	1.0		Watts	$P_{in} = 100$ mW See Fig. 1
η	Collector Efficiency (f = 400 MHz)	45		%	$P_{out} = 1.0$ W See Fig. 1
h_{fe}	High Frequency Current Gain (f = 200 MHz)	2.5			$I_C = 50$ mA $V_{CE} = 15$ V
C_{ob}	Output Capacitance (f = 1.0 MHz)		3.0	pF	$V_{CB} = 28$ V $I_E = 0$
h_{FE}	DC Pulse Current Gain (Note 5)	10	200		$I_C = 50$ mA $V_{CE} = 5.0$ V
h_{FE}	DC Pulse Current Gain (Note 5)	5.0			$I_C = 360$ mA $V_{CE} = 5.0$ V
$V_{CEO(sus)}$	Collector to Emitter Sustaining Voltage (Note 4)	30		Volts	$I_C = 5.0$ mA $I_B = 0$
BV_{CES}	Collector to Emitter Breakdown Voltage	55			$I_C = 5.0$ mA $V_{BE} = 0$
$V_{CE(sat)}$	Collector Saturation Voltage (Note 5)		1.0	Volts	$I_C = 100$ mA $I_B = 20$ mA
I_{CEO}	Collector Cutoff Current		20	μ A	$V_{CE} = 28$ V $I_B = 0$

*Planar is a patented Fairchild process.

NOTES:

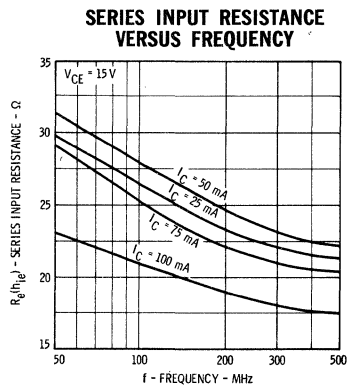
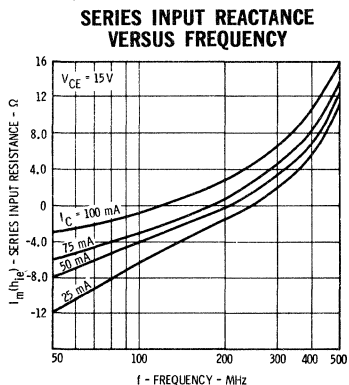
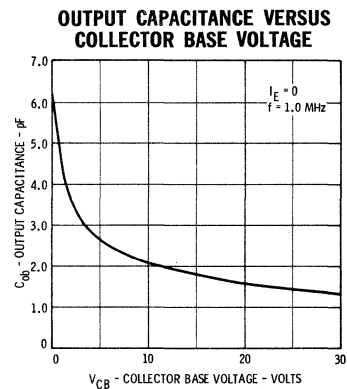
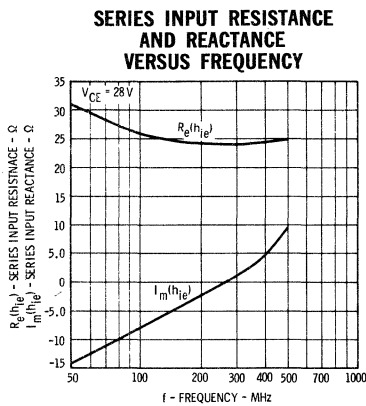
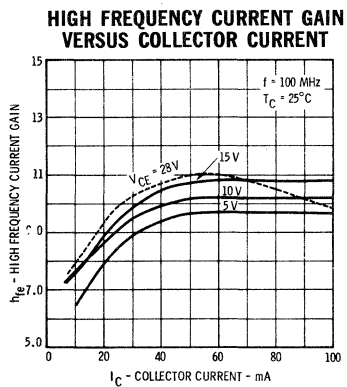
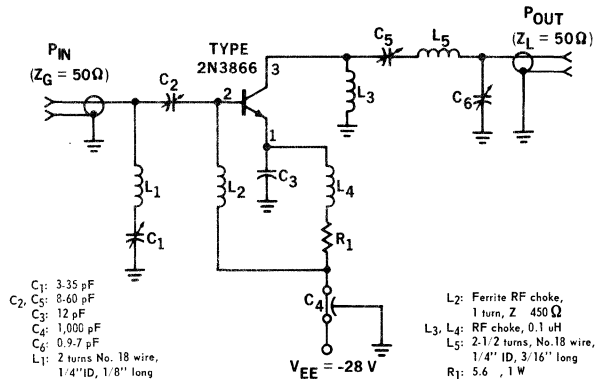
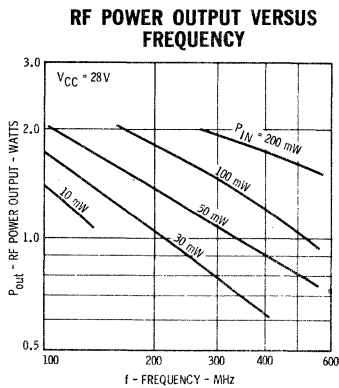
- (1) These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- (2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- (3) These ratings give a maximum junction temperature of 200°C and junction to case thermal resistance of 35°C/Watt (derating factor of 28.5 mW/°C).
- (4) This rating refers to a high current point where collector to emitter voltage is lowest.
- (5) Pulse Conditions: length = 300 μ s; duty cycle = 1%.

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RF PERFORMANCE

FIG. 1
RF AMPLIFIER CIRCUIT FOR POWER-OUTPUT TEST
(400 MHz/s Operation)



2N5025 • 2N5026

NPN VHF POWER TRANSISTORS

DIFFUSED SILICON PLANAR* EPITAXIAL TRANSISTORS

- **HIGH RF POWER GUARANTEE** -- 13.5 V operation: 20 W @ 50 MHz, Pin = 3.5 W
(Unneutralized, Class C) -- 28 V operation: 25 W @ 80 MHz, Pin = 2.5 W
- **HIGH V_{CE0} AND BV_{CES}** -- 13.5 V operation: 40 V and 75 V
-- 28 V operation: 50 V and 90 V
- **DISCRETE EMITTER GEOMETRY WITH INTEGRATED FEEDBACK RESISTORS**

ABSOLUTE MAXIMUM RATINGS [Note 1]

Maximum Temperatures

Storage Temperature

- 65°C to + 200°C

Operating Junction Temperature

+ 200°C

Lead Temperature (soldering, 60 second time limit)

+ 300°C

Maximum Power Dissipation

Total Dissipation at 25°C Case Temperature

45 Watts

(See Maximum Permissible DC Power Dissipation Curve and Note 5)

Maximum Voltages and Current

V_{CEO} Collector to Emitter Voltage [Note 4]

2N5025 40 Volts

2N5026 50 Volts

V_{CES} Collector to Emitter Voltage

2N5025 75 Volts

2N5026 90 Volts

V_{EBO} Emitter to Base Voltage

2N5025 4.5 Volts

2N5026 4.5 Volts

V_{CER} Collector to Emitter Voltage

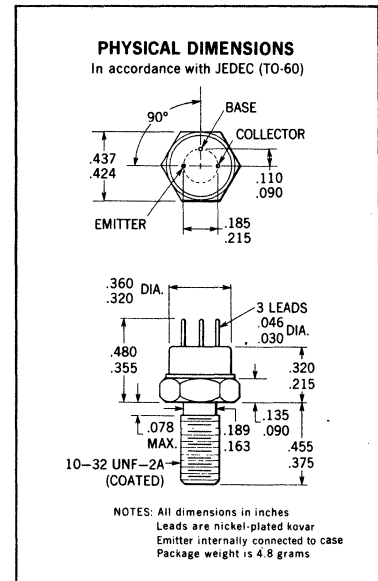
2N5025 40 Volts

2N5026 50 Volts

I_C Collector Current

2N5025 7.5 Amps

2N5026 7.5 Amps



ELECTRICAL CHARACTERISTICS (25°C Case Temperature unless otherwise noted)

SYMBOL	CHARACTERISTIC	2N5025			2N5026			UNITS	TEST CONDITIONS	
		MIN.	TYP.	MAX.	MIN.	TYP.	MAX.			
P_{out}	Power Output (f = 50 MHz)	20	22					Watts	$P_{in} = 3.5 W$	$V_{CC} = 13.5 V$
P_{out}	Power Output (f = 80 MHz)				25	30		Watts	$P_{in} = 2.5 W$	$V_{CC} = 28 V$
η	Collector Efficiency (f = 50 MHz)	65						%	$P_{out} = 20 W$	$V_{CC} = 13.5 V$
η	Collector Efficiency (f = 80 MHz)				65			%	$P_{out} = 25 W$	$V_{CC} = 28 V$
h_{fe}	High Frequency Current Gain (f = 50 MHz)	3.0	4.0		3.0	4.0			$I_C = 1.0 A$	$V_{CB} = 2.0 V$
C_{obo}	Collector Base Capacitance (f = 1.0 MHz)		54	85				pF	$V_{CB} = 13.5 V$	$I_E = 0$
C_{obo}	Collector Base Capacitance (f = 1.0 MHz)				43	60		pF	$V_{CB} = 28 V$	$I_E = 0$
BV_{CES}	Collector to Emitter Breakdown Voltage	75			90			Volts	$I_C = 5.0 mA$	$V_{BE} = 0$
$V_{CEO(sust)}$	Collector to Emitter Sustaining Voltage [Notes 2 and 4]	40	65		50	75		Volts	$I_C = 200 mA$	$I_B = 0$
BV_{CER}	Collector to Emitter Breakdown Voltage [Note 4]	40			50			Volts	$I_C = 200 mA$	$R_{BE} = 10 \Omega$
BV_{EBO}	Emitter to Base Breakdown Voltage	4.5			4.5			Volts	$I_E = 1.0 mA$	$I_C = 0$
h_{FE}	DC Pulse Current Gain [Note 3]	20	40		20	40			$I_C = 2.0 A$	$V_{CE} = 2.0 V$
$V_{CE(sat)}$	Pulsed Collector Saturation Voltage [Note 3]			1.0			1.0	Volts	$I_C = 2.0 A$	$I_B = 0.2 A$
$V_{BE(sat)}$	Pulsed Base Saturation Voltage [Note 3]			1.5			1.5	Volts	$I_C = 2.0 A$	$I_B = 0.2 A$
I_{CES}	Collector Cutoff Current			10				μA	$V_{CE} = 50 V$	$V_{BE} = 0$
I_{CES}	Collector Cutoff Current						10	μA	$V_{CE} = 60 V$	$V_{BE} = 0$
$I_{CES}(150^\circ C)$	Collector Cutoff Current			1.0				mA	$V_{CE} = 50 V$	$V_{BE} = 0$
$I_{CES}(150^\circ C)$	Collector Cutoff Current						1.0	mA	$V_{CE} = 60 V$	$V_{BE} = 0$

(See notes on back page)

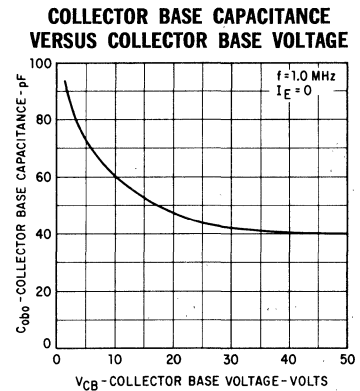
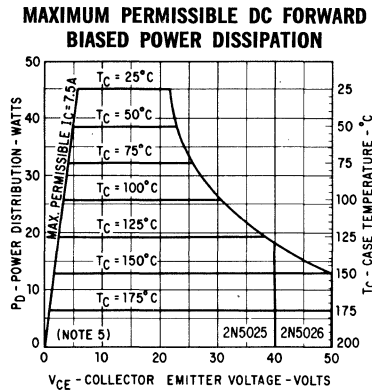
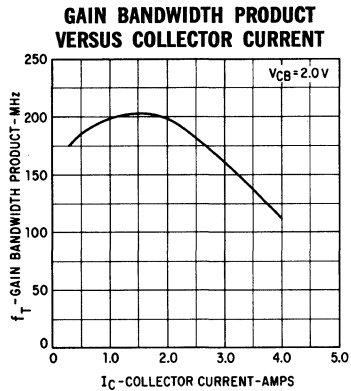
*Planar is a patented Fairchild process.

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SEMICONDUCTOR
A DIVISION OF FAIRCHILD CAMERA AND INSTRUMENT CORPORATION

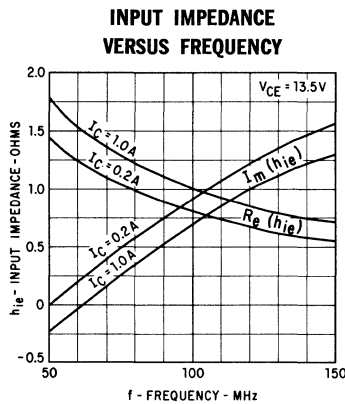
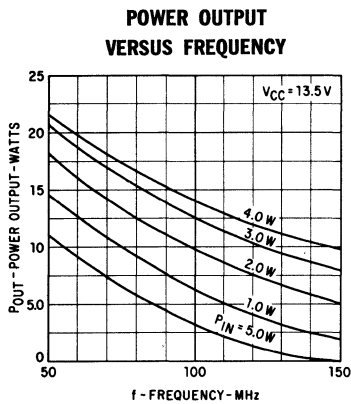
313 FAIRCHILD DRIVE, MOUNTAIN VIEW, CALIFORNIA, (415) 962-5011, TWX: 910-379-6435

FAIRCHILD TRANSISTORS 2N5025 • 2N5026

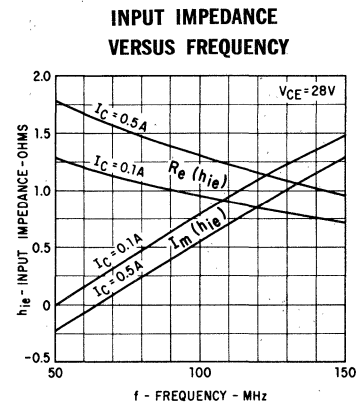
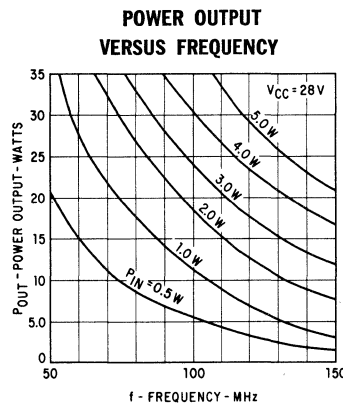
TYPICAL ELECTRICAL CHARACTERISTICS



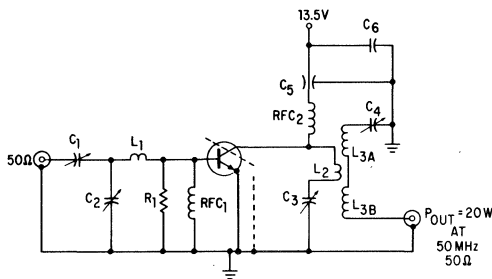
2N5025



2N5026

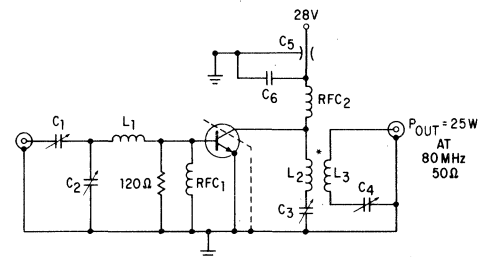


50 MHz AMPLIFIER TEST CIRCUIT



- C₁ = 9 - 180 pF (ARCO #463 or Equivalent)
 - C₂ = 50 - 380 pF (ARCO #465 or Equivalent)
 - C₃ = 50 - 380 pF (ARCO #465 or Equivalent)
 - C₄ = 4 - 40 pF (ARCO #403 or Equivalent)
 - C₅ = 1000 pF Feed - thru
 - C₆ = 1.0 μF, 50 WVDC
 - L₁ = 2t., 1/8" dia. copper tubing, 1/2" I.D., 3/8" long, 0.10 μH, Qu > 200
 - L₂ = 2t., 1/8" dia. copper tubing, 3/4" I.D., 7/16" long, 0.13 μH, Qu > 200
 - L_{3A} = 4t., 1/8" dia. copper tubing, 3/4" I.D., 3/4" long
 - L_{3B} = 6t., 1/8" dia. copper tubing, 3/4" I.D., 1" long } 1.0 μH, Qu > 200
 - R₁ = 120 Ω non-inductive
 - RFC₁ = 7 μH (Ohmite Z - 50 or Equivalent)
 - RFC₂ = 11t., #22 enameled wire, close-wound, 1/4" I.D., 0.3 μH
- Note:** L_{3A} & L_{3B} are wound continuously with 1/2" space between sections to admit L₂. kHz < K ≈ 0.2.

80 MHz AMPLIFIER TEST CIRCUIT



- C₁ = 16 - 150 pF (ARCO #424 or equivalent)
 - C₂ = 24 - 200 pF (ARCO #425 or equivalent)
 - C₃ = 4 - 40 pF (ARCO #422 or equivalent)
 - C₄ = 2 - 25 pF (ARCO #421 or equivalent)
 - C₅ = 1000 μF, Feed - thru
 - C₆ = 1.0 μF, 50 WVDC
 - L₁ = 1t., 1/8" dia. copper tubing, 3/8" I.D., 3/8" long, 0.01 μH, Qu > 200
 - L₂ = 3t., 1/8" dia. copper tubing, 3/4" I.D., 5/8" long, 0.2 μH, Qu > 200
 - L₃ = 6t., 1/8" dia. copper tubing, 3/4" I.D., 1 1/16" long, 0.6 μH, Qu > 200
 - RFC₁ = 7.0 μH (Ohmite Z-50 or equivalent)
 - RFC₂ = 11t., #20 Nylclad copper wire, close wound, 1/4" I.D., 0.3 μH
- Note:** Spacing between L₂ and L₃ is 1 turn. kHz < K ≈ 0.2

NOTES:

- (1) These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- (2) Ratings refer to a high-current point where collector to emitter voltage is lowest. For more information send for Fairchild Publication APP-4/2.
- (3) Pulse conditions: length = 300 μs; duty cycle = 1%.
- (4) Pulsed thru a 25MH inductor.
- (5) Contact factory for maximum permissible power under pulsed or reverse biased operating conditions.

MSA7505 • MSA8505

NPN VHF·UHF POWER TRANSISTORS

DIFFUSED SILICON PLANAR* EPITAXIAL TRANSISTORS

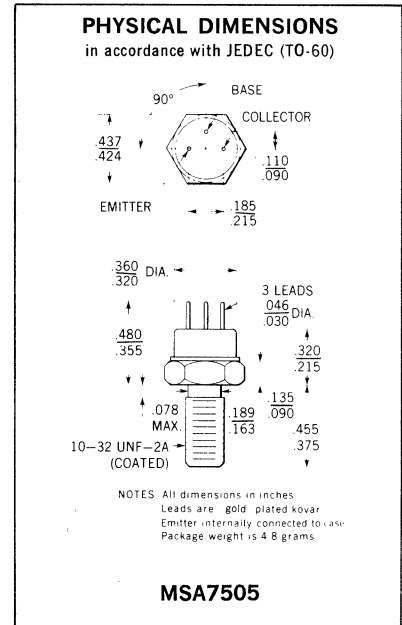
GENERAL DESCRIPTION — These devices are designed for use as RF Power Amplifiers with the maximum available safe operating area, thus making them ideal as drivers or output transistors for class A, B or C amplifier applications. These devices utilize Fairchild's unique discrete emitter thin film stabilizing resistors.

FEATURES

- HIGH POWER STABILITY THROUGH DISCRETE EMITTER THIN FILM RESISTORS
- MAXIMUM SAFE OPERATING AREA — NO SECOND BREAKDOWN TO 30 VOLTS
- IMPROVED HIGH FREQUENCY PERFORMANCE IN A LOW INDUCTANCE STRIPLINE PACKAGE (MSA8505)

ABSOLUTE MAXIMUM RATINGS (Note 1)

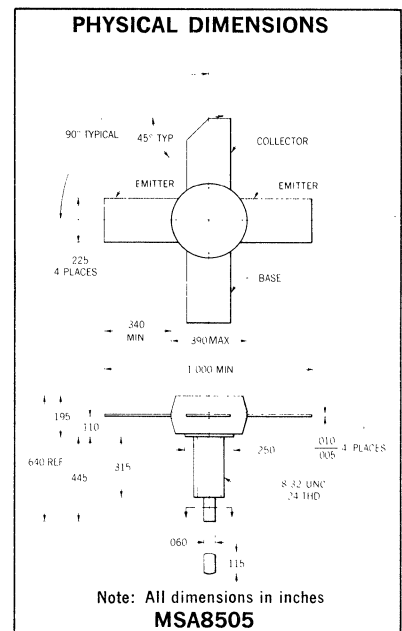
	MSA7505	MSA8505
Maximum Temperatures		
Storage Temperature	-65°C to +200°C	-65°C to +200°C
Operating Junction Temperature	200°C	200°C
Lead Temperature (Soldering, 10 seconds time limit)		
≥ 1/32" from Ceramic Disk	230°C	
≥ 1/4" from Encapsulated Area		270°C
Maximum Power Dissipation (Notes 2 and 3)		
Total Power Dissipation at 25°C Case Temperature	25 W	21 W
Maximum Voltages and Current		
V_{CE}		65 Volts
V_{CER}		55 Volts
V_{CEO}		33 Volts
V_{EBC}		4.0 Volts
I_C		3.0 A



ELECTRICAL CHARACTERISTICS (25°C Case Temperature unless otherwise noted)

SYMBOL	CHARACTERISTIC	MSA7505		MSA8505		UNITS	TEST CONDITIONS
		MIN.	TYP. MAX.	MIN.	TYP. MAX.		
P_{OUT}	Power Output (f = 400 MHz)			10		Watts	$P_{IN} = 2.75 W$ $V_{CC} = 28 V$
P_{OUT}	Power Output (f = 400 MHz)	10				Watts	$P_{IN} = 3.5 W$ $V_{CC} = 28 V$
η	Collector Efficiency (f = 400 MHz)	60		60		%	$P_{OUT} = 10 W$ $V_{CC} = 28 V$
h_{fe}	High Frequency Current Gain (f = 100 MHz)	2.5	4.35	2.5	4.35		$I_C = 0.5 A$ $V_{CE} = 3.0 V$
C_{ob}	Collector to Base Capacitance (f = 1.0 MHz)		20		20	pF	$I_C = 0$ $V_{CB} = 28 V$
$V_{CES(BR)}$	Collector to Emitter Breakdown Voltage	65		65		Volts	$I_C = 5.0 mA$ $V_{BE} = 0$
$V_{CER(BR)}$	Collector to Emitter Breakdown Voltage (Note 4)	55		55		Volts	$I_C = 200 mA$ $R_{BE} = 10 \Omega$
$V_{CEO(SUS)}$	Collector to Emitter Sustaining Voltage	33	45	33	45	Volts	$I_C = 50 mA$ $I_B = 0$
$V_{EBO(BR)}$	Emitter to Base Breakdown Voltage	4.0		4.0		Volts	$I_E = 1.0 mA$ $I_C = 0$
h_{FE}	DC Pulse Current Gain (Note 5)	10		10			$I_C = 1.0 A$ $V_{CE} = 5.0 V$
I_{CES}	Collector Cutoff Current		5.0		5.0	mA	$V_{CE} = 65 V$ $V_{BE} = 0 V$
$I_{CES(150^\circ C)}$	Collector Cutoff Current		5.0		5.0	mA	$V_{CE} = 30 V$ $V_{BE} = 0 V$

See Notes on Page 2

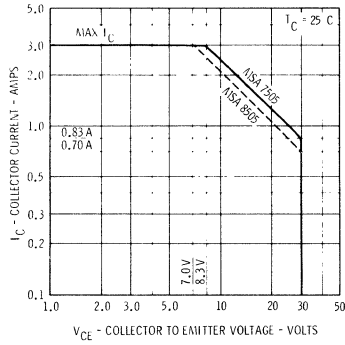


*Planar is a patented Fairchild process.

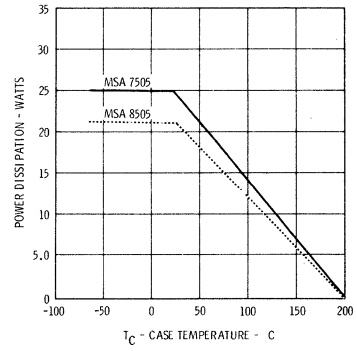
FAIRCHILD
SEMICONDUCTOR
A DIVISION OF FAIRCHILD CAMERA AND INSTRUMENT CORPORATION

SAFE OPERATING AREA

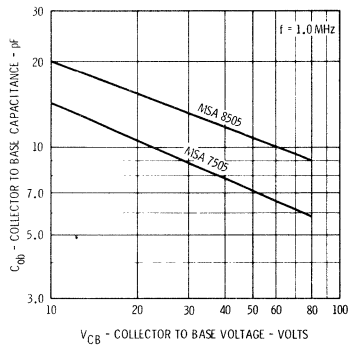
DC SAFE OPERATING AREA CURVE



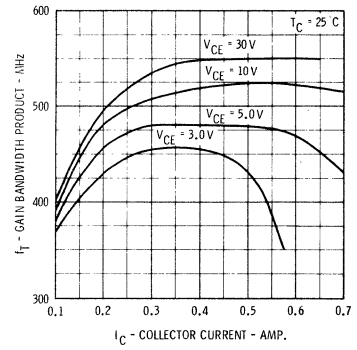
POWER DISSIPATION DERATING CURVE



COLLECTOR TO BASE CAPACITANCE VERSUS COLLECTOR TO BASE VOLTAGE



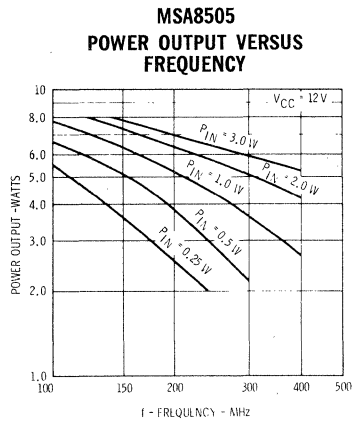
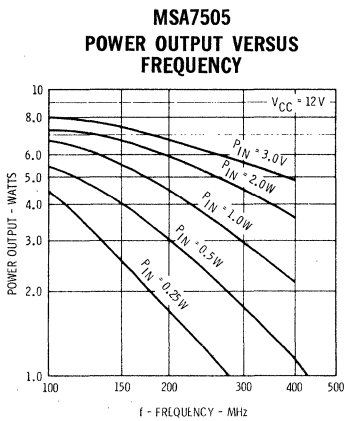
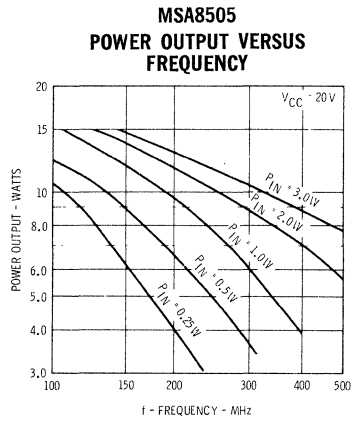
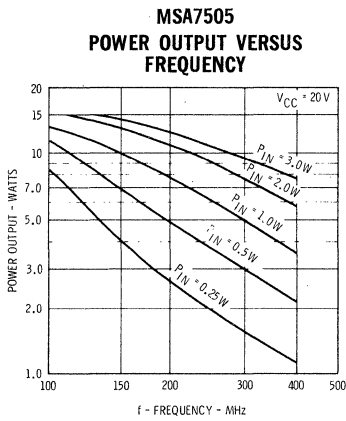
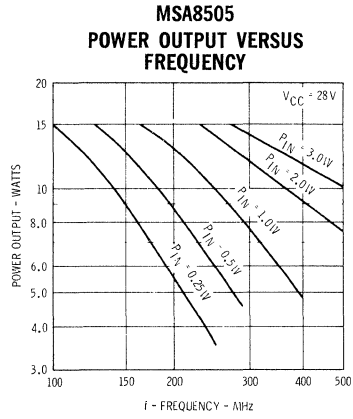
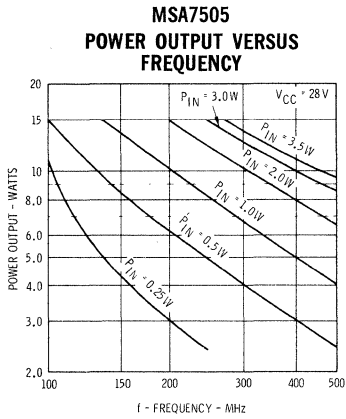
GAIN BANDWIDTH PRODUCT VERSUS COLLECTOR CURRENT



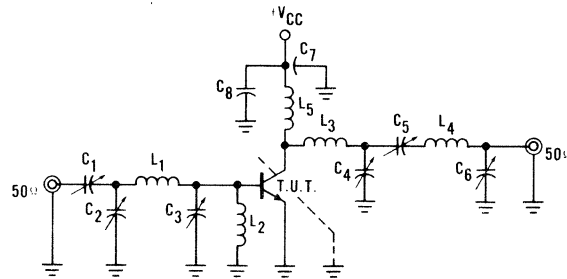
NOTES:

- (1) These ratings are limiting values above which the servcability of any individual semiconductor device may be impaired.
- (2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- (3) These ratings give a maximum junction temperature of 200°C and junction to case thermal resistance of 7.0°C/Watt for MSA7505 and 8.34°C/Watt for MSA8505.
- (4) Pulsed through a 25 mH inductor.
- (5) Pulse Conditions: length = 300 μs; duty cycle ≤ 2%.

TYPICAL POWER OUTPUT VERSUS FREQUENCY AND VOLTAGE

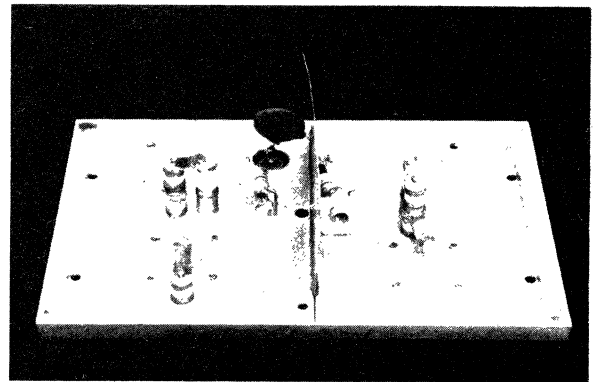
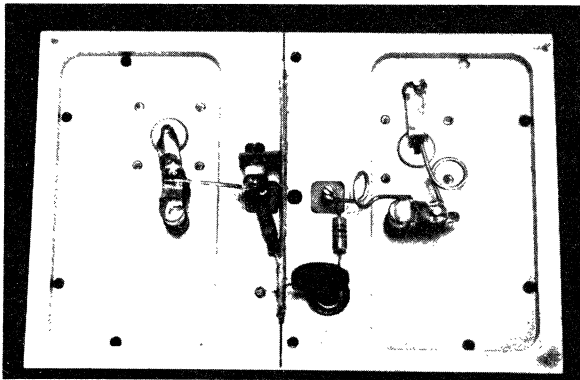


400 MHz RF TEST AMPLIFIER



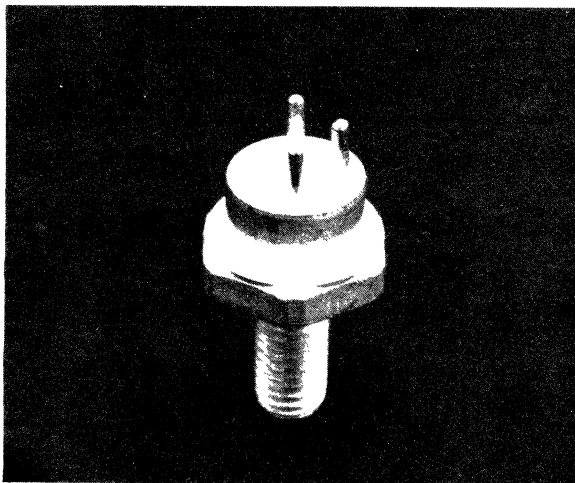
C₁, C₃, C₅, C₆: 1-10 pF
 C₂, C₄: 1-20 pF
 C₇: 1000 pF
 C₈: 0.1 μF disk

L₁: 1", #16, TC
 L₂: .15 μH RFC with ferrite bead
 L₃, L₄: 1T, 5/16" d, #16, TC
 L₅: .15 μH RFC



PACKAGE PICTURES

MSA7505



MSA8505

